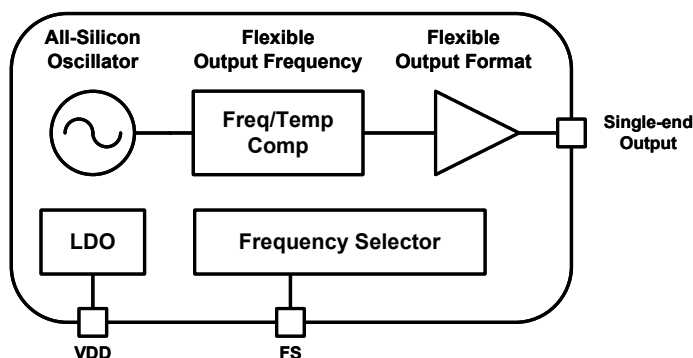


AS512 Low Jitter Multi-Configuration LVCMOS Silicon Oscillator

Description

The AS512 Arcadium™ all-silicon CMOS oscillator utilizes proprietary frequency synthesis and sensor technologies to provide a quartz-free, MEMS-free, low jitter clock at any output frequency. The device is factory-programmed to have 3 selectable frequencies ranging from 10 kHz to 212.5 MHz with ± 0.026 ppb resolution and maintains low jitter across its operating range. It uses on-chip temperature and strain sensors, and an advanced LC tank architecture to achieve excellent reliabilities even in high impact shock scenarios.

AS512's on-chip power supply filtering provides industry-leading power supply noise rejection, simplifying the task of generating low jitter clocks in noisy systems that use switched-mode power supplies. Offered in an industry-standard 3225 and 5032 package, the AS512 has a dramatically simplified supply chain that enables Aeonsemi to ship samples shortly after receipt of order. Specific frequencies are factory programmed at time of shipment, eliminating the long lead times associated with custom frequencies. This process also guarantees 100% electrical testing of every device before shipment.



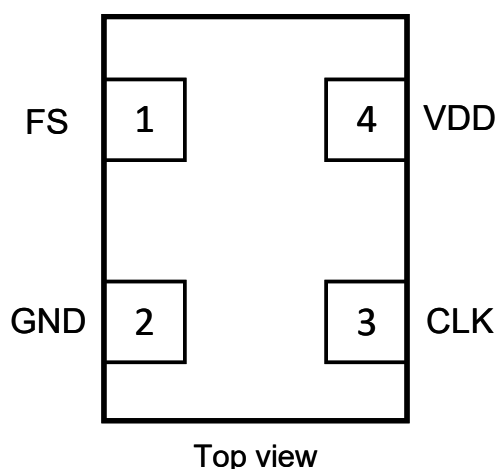
Key Features

- Quartz-free and MEMS-free without mechanical moving parts
- LVCMOS output: 10 kHz to 212.5 MHz
- Low jitter: 350 fs Typ (12 kHz – 20 MHz, @156.25 MHz)
- Temperature stability:
 - ± 20 ppm (-20 to 85 °C)
 - ± 35 ppm (-40 to 85 °C)
 - ± 35 ppm (-40 to 105 °C)
- Selectable configurations by FS pin
- Integrated LDO for on-chip power supply noise filtering
- Support 1.8V, 2.5V, 3.3V V_{DD} supply operation
- Industrial standard 3225 and 5032 package footprints

Application

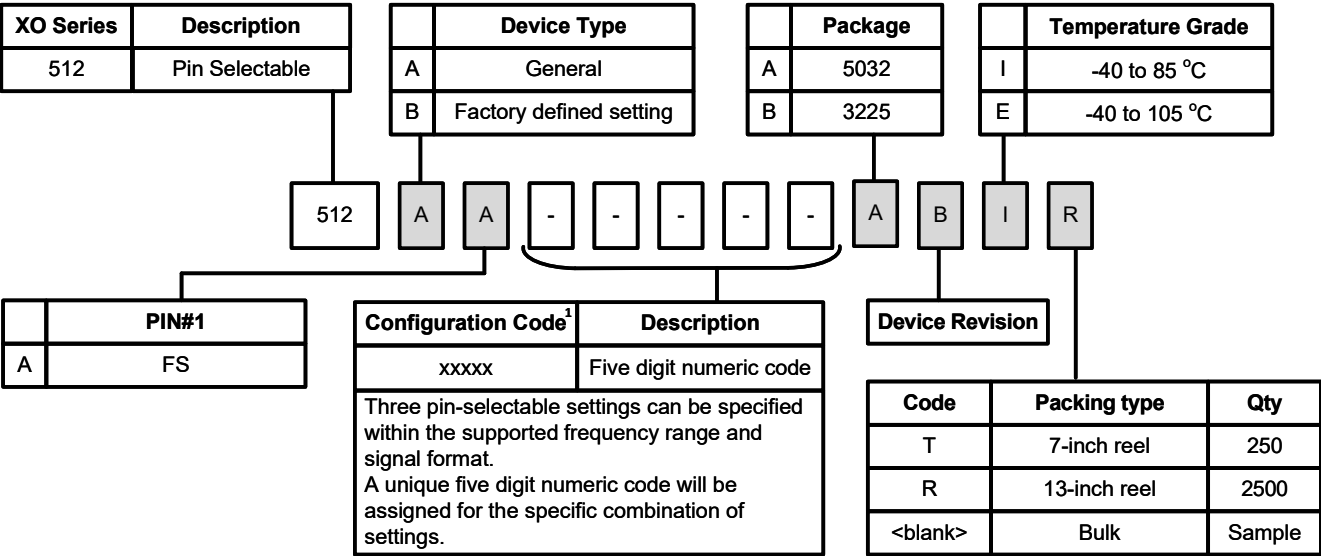
- 1G/10G/40G/100G/200G Ethernet
- Servers, switches, storage, NICs, search acceleration
- Test and measurement
- Clock and data recovery
- FPGA/ASIC clocking

Pin definition



Pin#	Description
1	FS = Tri-state configuration selector
2	GND = Ground
3	CLK = Clock output
4	VDD = Power supply

1. Ordering Guide



Note:

- 1. The five-digit numeric code is an identification of the configurations. Check the datasheet appendix for the details.

2. Function Description

2.1. Overview

The AS512 is a configuration selectable oscillator that generates reference clocks with any output frequencies (10 kHz – 212.5 MHz) LVCMOS clock, Pin1 of AS512 is designed as configuration selector (FS).

2.2. Configuration Selector

The on chip Non-Volatile Memory (NVM) stores three pre-programmed output frequencies. It selects an output frequency using the configuration selector pin (FS). Configurations can be customized at aeonsemi.com/AS512/customize

Table 2.1. shows an example of a configuration:

Table 2.1. A Configuration Example with 3 Pre-Programmed Configurations

FS (Pin1)	Output Frequency
Low	27 MHz
Hi-Z	50 MHz
High	100 MHz
Notes: AS512 supports options of VCXO and SSC (Spread Spectrum Clock) feature on the control pin. Contact aeonsemi.com/contact_us for the advanced configurations.	

3. Electrical Specifications

Table 3.1. Electrical Specifications

Parameter	Symbol	Min	Typ	Max	Unit	Note
Operating Temperature Range						
Temperature Range	T _A	-40	—	85	°C	Industrial grade
		-40	—	105	°C	Extended industrial grade
Supply Voltage and Power Consumption						
Supply Voltage	V _{DD}	1.71	—	3.47	V	
Supply Current (F _{CLK} = 50 MHz)	I _{DD}	—	40	50	mA	Tristate Hi-Z (OE = 0)
		—	1	2	mA	Ready State (ACT = 0)
		—	40	55	mA	LVC MOS output (C _L = 15 pF)
Frequency Range						
Frequency Range	F _{CLK}	0.01	—	212.5	MHz	LVC MOS output
Frequency Tolerance						
Initial frequency accuracy	F _{INIT}	-10	—	10	ppm	Inclusive of initial frequency tolerance at 25 °C and variations over supply voltage, load and humidity after soldering-reflow shift settles.
Temperature stability	F _{STAB}	-20	—	20	ppm	-20 - 85 °C
		-35	—	35	ppm	-40 - 85 °C
		-35	—	35	ppm	-40 - 105 °C
Aging	F _{AGING}	-5	—	5	ppm	10 Year at 25 °C
IO Characteristics						
Configuration selector (FS)	V _{IH}	0.7×V _{DD}	—	—	V	Input high voltage
	V _{IL}	—	—	0.3×V _{DD}	V	Input low voltage
	R _{PUP}	—	50	—	kΩ	Internal pull-up resistor to V _{DD}
	R _{PDOWN}	—	50	—	kΩ	Internal pull-down resistor to GND
Output Characteristics						
Powerup time	T _{OSC}	—	—	4	ms	Time from power reaches 0.9 × V _{DD} to output frequency (F _{CLK}) within spec
Duty cycle	DC	45	—	55	%	LVC MOS (C _L = 15 pF)
Rise/Fall time (20% to 80% VPP)	T _{R/F}	—	0.5	1.5	ns	LVC MOS (C _L = 15 pF)
LVC MOS	V _{OH}	0.83×V _{DD}	—	—	V	C _L = 15 pF
	V _{OL}	—	—	0.17×V _{DD}	V	

Continued on next page

Parameter	Symbol	Min	Typ	Max	Unit	Note
Phase Noise and Jitter						
RMS jitter BW: 12k - 20MHz	R _J	—	350	750	fs	F _{CLK} ≥ 100 MHz
		—	450	750	fs	F _{CLK} ≥ 25 MHz
Phase noise	PN _{1k}	—	-83	—	dBc/Hz	Phase noise at 1kHz offset
Phase noise	PN _{10k}	—	-111	—	dBc/Hz	Phase noise at 10kHz offset
125MHz LVCMOS output	PN _{100k}	—	-134	—	dBc/Hz	Phase noise at 100kHz offset
V _{DD} = 1.8 - 3.3V	PN _{1M}	—	-150	—	dBc/Hz	Phase noise at 1MHz offset
	PN _{10M}	—	-159	—	dBc/Hz	Phase noise at 10MHz offset
PSRR						
Spurs from power noise 50mV ripple V _{DD} = 1.8V	PSRR	—	-76	—	dBc	100 kHz sine wave
		—	-75	—	dBc	200 kHz sine wave
		—	-75	—	dBc	500 kHz sine wave
		—	-75	—	dBc	1 MHz sine wave
Spurs from power noise 50mV ripple V _{DD} = 2.5 or 3.3V	PSRR	—	-83	—	dBc	100 kHz sine wave
		—	-83	—	dBc	200 kHz sine wave
		—	-83	—	dBc	500 kHz sine wave
		—	-82	—	dBc	1 MHz sine wave
Thermal Resistance						
Thermal resistance 5032 4-pin DFN Still air	θ _{JA}	—	105	—	°C/W	Junction to ambient
	θ _{JB}	—	81	—	°C/W	Junction to board
	T _J	—	125	—	°C/W	Maximum junction temperature
Thermal resistance 3225 4-pin DFN Still air	θ _{JA}	—	108	—	°C/W	Junction to ambient
	θ _{JB}	—	84	—	°C/W	Junction to board
	T _J	—	125	—	°C/W	Maximum junction temperature

Table 3.2. Environmental Compliance and Package Information

Parameter	Value
Moisture sensitivity level (MSL)	1
Notes: For additional product information not listed in the data sheet (e.g. RoHS Certifications, MSDS data, qualification data, REACH Declarations, ECCN codes, etc.), contact aeonsemi.com/contact_us	

Table 3.3. Absolute Maximum Ratings¹

Parameter	Symbol	Rating	Unit
Maximum operating temperature	T_{AMAX}	125	°C
Storage temperature	T_S	-55 - 125	°C
Supply voltage	$V_{DD,MAX}$	-0.5 - 3.8	V
Input voltage	$V_{IN,MAX}$	-0.5 - $V_{DD}+0.3$	V
ESD HBM (JESD22-A114)	HBM	4.0	kV
ESD CDM (JESD22-C101)	CDM	1.0	kV
Solder Temperature ²	T_{PEAK}	260	°C
Solder time at T_{PEAK} ²	T_P	20 - 40	sec
Notes: 1. Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability. 2. The device is compliant with JEDEC J-STD-020.			

4. Package Outline Drawing

Figure 4.1. shows the package outline drawing for the AS512 devices. Details of dimension for different size options are listed in Table 4.1.

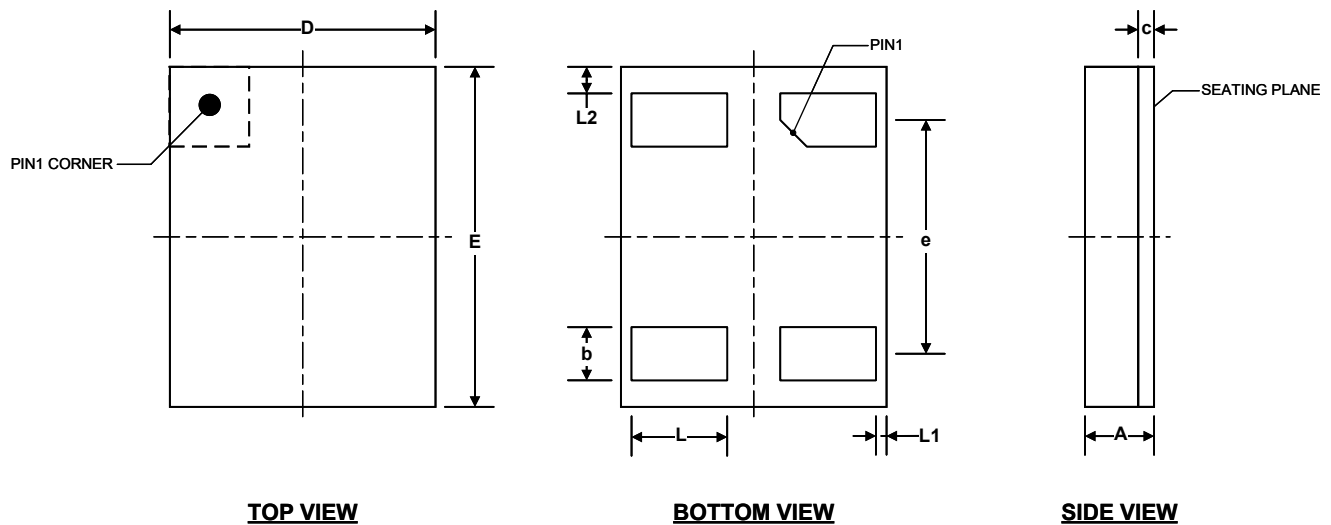


Figure 4.1. Package Outline Drawing

Table 4.1. Dimensions of Package Outline Drawing (mm)

Symbol	5032 Package	3225 Package
A	0.85 ± 0.05	0.85 ± 0.05
b	0.64 ± 0.05	0.90 ± 0.05
D	3.20 ± 0.10	2.50 ± 0.10
e	2.54 BSC	2.10 BSC
E	4.00 ± 0.10	3.20 ± 0.10
L	0.94 ± 0.05	0.70 ± 0.05
L1	0.10 ± 0.05	0.10 ± 0.05

5. Recommended PCB Land Pattern

Figure 5.1. shows the drawing of recommended PCB land pattern for the AS512 devices. Details of dimension for different size options are listed in Table 5.1.

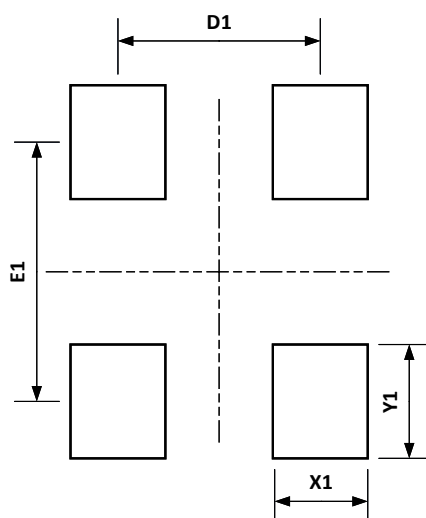


Figure 5.1. Recommended PCB Land Pattern

Table 5.1. Dimensions of Recommended PCB Land Pattern (mm)

Symbol	5032 Package	3225 Package
D1	2.16	1.70
E1	2.54	2.10
X1	1.24	1.00
Y1	0.84	1.10

Notes:

The following notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine-tune their SMT process as required for their application and tooling.

General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125 mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 0.8 1 for the pads.

Card Assembly

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6. Top Mark

Figure 6.1. shows the top mark specifications for the AS512 devices. Description of each line is listed in Table 6.1.

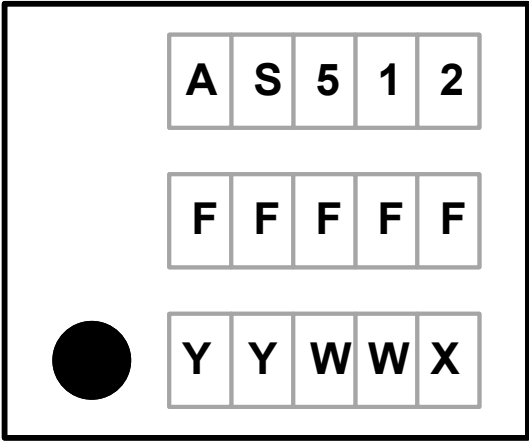


Figure 6.1. Top Mark

Table 6.1. Top Mark Description

Line	Position	Description
1	1-6	Device Name
2	1-5	Unique 5-digit Device Configuration Number
3	1	Pin 1 orientation mark (dot)
	2-3	Year (last two digits of the year), to be assigned by assembly site (ex: 2025 = 25)
	4-5	Calendar Work Week number (1-53), to be assigned by assembly site
	6	Manufacturer code

7. Packing Specification

Figure 7.1. shows the packing specifications for the AS512 devices. Details of the tape specifications are listed in Table 7.1.

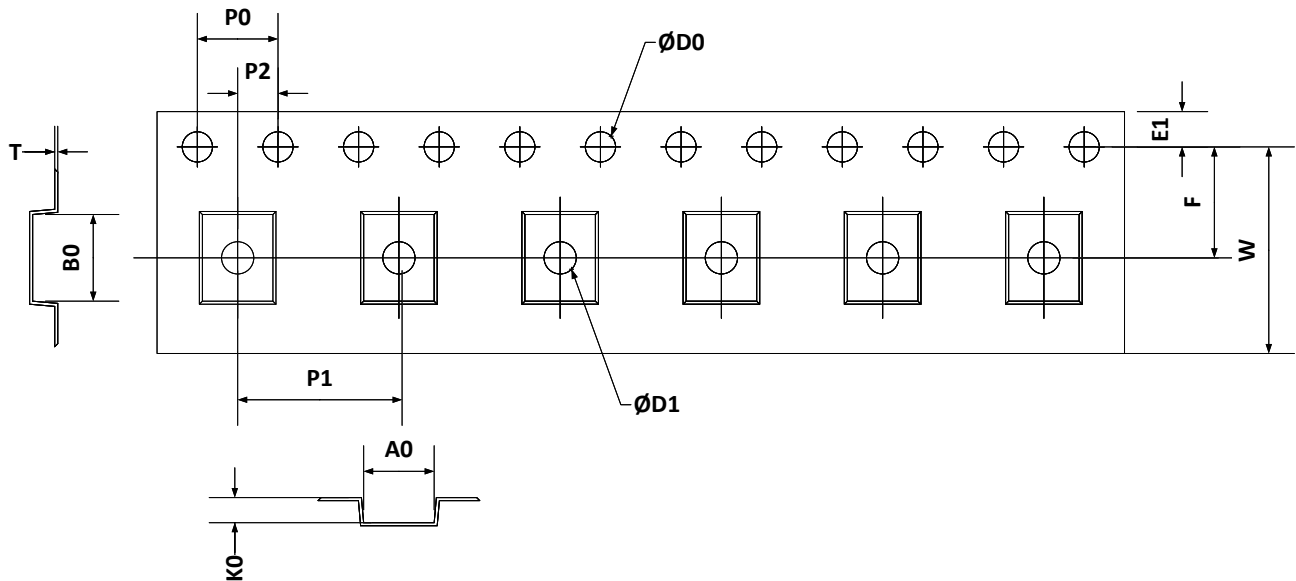


Figure 7.1. Tape Specification

Table 7.1. Dimensions of Tape (mm)

Symbol	5032 Package	3225 Package
A0	3.50 ± 0.10	2.80 ± 0.10
B0	4.30 ± 0.10	3.50 ± 0.10
K0	1.25 ± 0.10	1.05 ± 0.10
E1	1.75 ± 0.10	1.75 ± 0.10
F	5.50 ± 0.05	5.50 ± 0.05
W	12.00 ± 0.30	12.00 ± 0.30
T	0.30 ± 0.05	0.30 ± 0.05
P0	4.00 ± 0.10	4.00 ± 0.10
P1	8.00 ± 0.10	8.00 ± 0.10
P2	2.00 ± 0.05	2.00 ± 0.05
ØD0	1.50 ± 0.10	1.50 ± 0.10
ØD1	1.60 ± 0.10	1.60 ± 0.10

8. Important Notice and Disclaimer

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9. Revision History

Revision	Date	Description
1.13	Aug 2025	Corrected the tape specification
1.12	Aug 2024	Add packing specification
1.11	Mar 2024	Updated the frequency offset
1.10	Jul 2022	Updated the top mark specification
1.01	Dec 2021	Adjusted the PCB land pattern dimensions
1.00	Sep 2021	With certain specification update
0.95	Jun 2021	Corrected the Ordering Guide Insert -40 - 105 °C temperature range option Insert section "IMPORTANT NOTICE AND DISCLAIMER"
0.20	Mar 2021	Changed the frequency range and ordering guide
0.10	Feb 2021	Initial release